Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination TYAN ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0117678 A1	06-2003	Chang et al.	359/157
*	В	US-2003/0179716 A1	09-2003	Liu, Kevin H.	370/254
*	С	US-2003/0043745 A1	03-2003	Kano et al.	370/238
	D	US-		·	
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					•
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	Р					
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	R					
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	Т					

NON-PATENT DOCUMENTS

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